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IN THE U.S. PATENT AND TRADEMARK OFFICE

June 24, 2005

Applicants : Kunio SEKIYA et al
For : METHOD FOR PROVIDING CANVAS OF PAPER-MAKING
MACHINE WITH ANTI-STAINING AGENT THROUGH
SPRINKLING, AND SLIDING SPRINKLE DEVICE AND
ANTI-STAINING AGENT FOR USE THEREIN

PCT International Application No.: PCT/JP2003/016799

PCT International Filing Date: December 25, 2003

U.S. Application No.

(if known, see 37 CFR 1.5): Unknown

Atty. Docket No.: 4414.P0673US

Mail Stop PCT
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Sir:

In compliance with the provisions of Rules 1.97(b)(1) and 1.98, enclosed herewith is a copy of the International Search Report, Form PTO-1449 and the references cited thereon. The relevance of these references is explained on the enclosed search report. Accordingly, further comment at this point in time should not be necessary.

Respectfully submitted,


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Encl: Copy of International Search Report
Form PTO-1449 and one copy of each reference listed

thereon
ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /M.H./
(00003313.DOC)

INFORMATION
DISCLOSURE
CITATION

10-540617

Applicant: Egi Sekiya et al
Ser. No.: Unknown
Conf. No.: Unknown
Group: Unknown

Filed: Unknown
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U. S. PATENT DOCUMENTS

Examiner Initials*	Cite No.	Document Number - Kind Code	Publication Date MM-DD-YYYY	Name of Patentee or Applicant
	AA	4 597 526	07/01/1986	Egi et al
	AB	4 753 712	06/28/1988	Martin et al
	AC			
	AD			
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	AH			
	AI			
	AJ			
	AK			

FOREIGN PATENT DOCUMENTS

Examiner Initials*	Cite No.	Country Code - Document Number - Kind Code	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Trans.
	AL	EP 1 124 005 A1	08/16/2001	Sekiya	
	AM	JP 2000-96476	04/04/2000		No
	AN	GB 2 284 833 A	06/21/1995	Finch	
	AO				
	AP				

NON PATENT LITERATURE DOCUMENTS

Examiner Initials*	Cite No.	(Include Author, Title, Date, Pages, Etc.)
	AQ	
	AR	
EXAMINER SIGNATURE		DATE CONSIDERED
/Mark Halpern/		9/10/08

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.